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EMC TEST REPORT For FCC

Test Report No. CTK02-F026 :

Date of Issue February 7, 2002

Model/Type No: Digimax 350SE

Kind of Product Digital Camera

Applicant Samsung Techwin Co.,Ltd. :

Applicant Address #145-3, Sandaewon 1-Dong, Sungnam-Shi, Kyonggi-Do, Korea

Manufacturer Samsung Techwin Co.,Ltd.

Manufacturer Address #145-3, Sandaewon 1-Dong, Sungnam-Shi, Kyonggi-Do, Korea

Contact Person Mr. G. S. Kim (Manager)

Telephone +82-31-740-8253

Received Date February 4, 2002

Test period Start: Feb 4, 2002 End: Feb. 6, 2002

■ Not in Compliance Test Results

The test results presented in this report relate only to the object tested.

CERTITEK Standards Laboratory Co., Ltd. is accredited by Korea Laboratory Accreditation Scheme (KOLAS) which signed the International Laboratory Accreditation Cooperation (ILAC) Mutual Recognition Arrangement (MRA) for the above test item(s) and test method(s).

Tested by

Michael Jang

EMC Test Engineer

Date: February 7, 2002

Reviewed by

James Hong

EMC Technical Manager

Date: February 7, 2002



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REPORT REVISION HISTORY

Date	Revision	Page No
Feb. 7, 2002	(CTK02-F026) Issued	All

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1.0 General Product Description

The product is a Digital Camera.

1.0.1	✓ UnlessModel I☐ Tests p	Unless otherwise indicated, all tests were conducted on Model Digimax 350SE. Tests performed on Model were considered to be representative of Model(s)						
1.0.2	Equipment S	Size, Mobility and Identification						
	Dimensions: Mobility: Serial No.:	114 by 70 by 49.9						
1.0.3	Electrical Ra	tings						
	Input:	1. EUT: DC 6.0V 2. Adaptor: AC 100-250V, 50-60Hz, 0.3A						
	Output:	1. EUT : Not applicable 2. Adaptor : DC 6.0V, 2A						
1.0.4	Test Voltage	e & Frequency (Using the Adaptor)						
		ed otherwise on the individual data sheet or test results, the test equency was as indicated below.						
	Voltage: Frequency:	120VAC 60Hz						
1.0.5	Clock & Oth	er Frequencies Utilized						
	HOST-CPU: 6. TG & CDS+A/D Image Processo							

1.1 Model Differences

Not applicable

1.2 Device Modifications

The following modifications were necessary for compliance:

Not applicable

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1.3 EUT Configuration(s)

See Appendix A for individual test set-up configuration(s). The following peripheral devices and/or interface cables were connected during the measurement:

Peripheral Devices

Device	Manufacturer	Model No.	Serial No.	FCC ID or DoC
Adaptor	Ault Korea	PW115KA0600N01	-	-
Notebook Computer	I & B COM	Slim 5360	MB0VAA111100094	DOC
PRINTER	Seiko Epson	Stylus Color 460	BWCE136524	DOC
MOUSE (Serial type)	Microsoft	BASM1	4475951-20000	DOC
KEYBOARD	World Com Mart	KB120	-	D840902 MIC
HEADSET	CAMAC	CMK-C3	-	-

□ Cable Description

			Length	
#	Description	Ferrited	(m)	Other Details
1	USB cable, Shielded	Yes	1.8	Between the EUT and notebook
2	DC output cable, Unshielded	Yes	1.8	Between the EUT and adaptor
3	AC power cable, Unshielded	No	1.5	For the EUT connect to AC power
4	A/V cable, Unshielded	Yes	1.5	-
5	AC power cable, Unshielded	No	1.8	For notebook connect to AC power
6	AC power cable, Unshielded	No	1.8	For printer connect to AC power
7	Printer cable, Shielded	Yes	1.8	Connect to notebook
8	Line In cable, Unshielded	No	1.5	-
9	Keyboard cable, Shielded	No	2.0	PS/2 Type
10	Headset cable, Unshielded	No	2.0	-
11	Mouse cable, Shielded	No	2.0	Serial Type

n/a = not available

1.4

Test Software

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1.6 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable to the Korea Research Institute of Standards and Science (KRISS), therefore, all test data recorded in this report is traceable to KRISS.

1.7 Test Facility

The measurement facility is located at 386-1, Ho-Dong, Yongin-City, Kyungki-Do, Korea 449-100. The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22.

1.8 Measurement Procedure

Preliminary AC power line conducted emissions tests were performed shielded room. To find worst mode, several typical mode and typical cable position were tested. Final AC power line conducted emissions test was performed shielded room. (location is same as Preliminary test)

Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

Preliminary radiated emissions test were performed anechoic chamber (Distance of antenna and EUT was 3 m). To find worst mode, several typical mode and typical cable position were tested and peak level and frequency were recorded.

Final radiated emissions test was performed Open Area Test Site. Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

* Measurement procedures was In accordance with ANSI C63.4-1992 7.2.3, 7.2.4, 8.3.1.1, 8.3.1.2

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1.9 Laboratory Accreditations and Listings

Country	Agency	Scope of Accreditation	Logo
USA	FCC	3 and 10 meter Open Area Test Sites to perform FCC Part 15/18 measurements.	FC 93250
JAPAN	VCCI	10 meter Open Area Test Site and one conducted site.	P -948, C-986
KOREA	MIC	EMI (CE, RE) EMS (ESD, Burst, RS, Surge, CS, Power-Frequency Susceptibility, Voltage Dips and Short Interruptions)	No. 51, KR0025
International	KOLAS	EMC	KOLAS NO.11P

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Emissions Test Regulations 2.0

The emissions tests were performed according	to following regulations:	
☐ EN 50081-1 /1992		
□ EN 55011 /1998	☐ Group 1 ☐ Class A	☐ Group 2 ☐ Class B
☐ EN 55013 /A12:1994		
□ EN 55014 /1987	☐ Household appliance☐ Portable tools☐ Semiconductor dev	
☐ EN 55014 /A2:1990		
□ EN 55014 /1993	☐ Household appliance☐ Portable tools☐ Semiconductor dev	
☐ EN 55015 /1987 ☐ EN 55015 /A1:1990 ☐ EN 55015 /1993		
☐ EN 55022 /A1:1995	☐ Class A	☐ Class B
□ EN 55022 /1998	☐ Class A	☐ Class B
☐ EN 61000-3-2 /1995 (EN 60555 Part 2 /4.87 ☐ EN 61000-3-3 /1995 (EN 60555 Part 3 /4.87		
□ BS		
☐ VCCI V-3/99.05 : 1999	☐ Class A	☐ Class B
☐ FCC Part 15 SUBPART B	☐ Class A	☐ Class B
☐ AS 3548 (1992)	☐ Class A	☐ Class B
☐ CISPR 11 (1990)	☐ Group 1 ☐ Class A	☐ Group 2 ☐ Class B
☑ CISPR 22 (1993)	☐ Class A	⊠ Class B

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2.1 Conducted Voltage Emissions

Test Date February 5, 2002 **Test Location** EMI-CE: Shielded Room **Test Instruments** □ Field Strength Meter Rohde Schwarz ESHS30 828144/002 **Test Accessories** ☐ LISN 9206-1971 **EMCO** 3825/2 LISN **EMCO** 3825/2 9409-2246 □ LISN **EMCO** 3825/2 9607-2574 □ Control PC HP Vectra 500 SG72000192 **Frequency Range of Measurement** □ 150 kHz to 30 MHz ☐ 450 kHz to 30 MHz **Instrument Settings** IF Band Width: 9 kHz **Test Results** The requirements are: minimum margin is 4.6 dB μ V at 16.00 MHz

limit exceeded by maximum of ____ dB μV at ____ MHz

Remarks

☐ NOT MET

☐ NOT APPLICABLE

See Appendix A for test data.

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2.2 Radiated Electric Field Emissions

Test Date February 6, 2002 **Test Location** ☑ EMI-OATS: Testing was performed at a test distance of 10 m. ☐ EMI-OATS: Testing was performed at a test distance of 3 m **Test Instruments** Rohde Schwarz ESVS30 826638/008 **Test Accessories** ☑ ULTRA Broadband Antenna R & S HL562 361324/014 ☐ Biconical Antenna Schwarzbeck BBA9106 41-00201 ☐ Biconical Antenna **EMCO** 3110B 9607-2564 ☐ Log-periodic Antenna **EMCO** 3146 9607-4567 **Frequency Range of Measurement** 30 MHz to 1 GHz **Instrument Settings** IF Band Width: 120 kHz **Test Results** The requirements are: minimum margin is 3.08 dB (μ V/m) at 108.30 MHz limit exceeded by maximum of ____ dB(μ V/m) at ____ MHz □ NOT MET

See Appendix A for test data

☐ NOT APPLICABLE

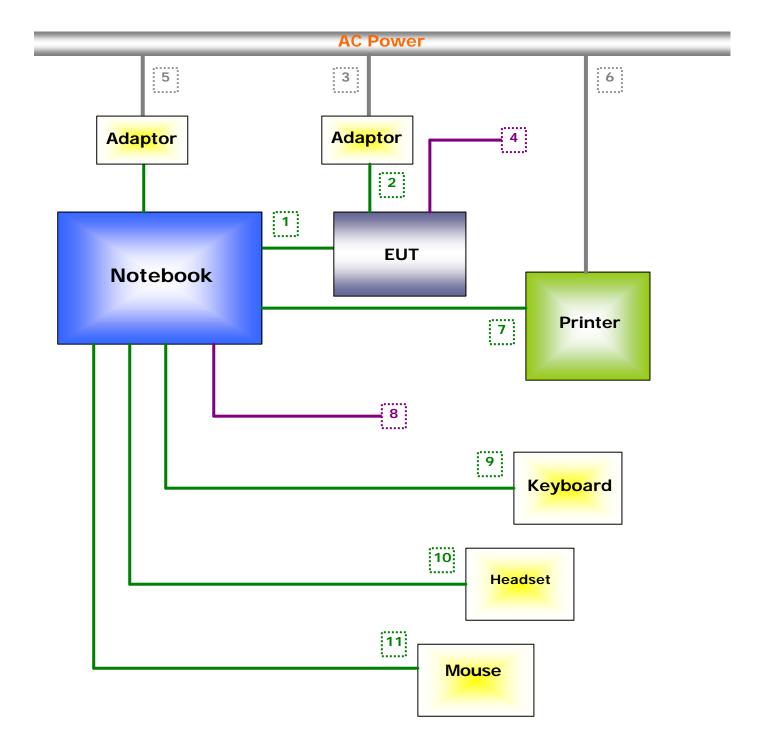
Remarks

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Configuration







APPENDIX A - TEST DATA

Conducted Voltage Emissions (Quasi-Peak reading)

Frequency	Correction				Quasi	-peak			Avei	rage	
. ,	Fac	ctor	Line	Limit	Reading	Result	Margin	Limit	Reading	Result	Margin
[MHz]	LISN	Cable		[dBuV]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dB]
16.00	0.4	0.2	N	60.0	54.8	55.4	4.6	50.0	38.4	39.0	11.0
16.35	0.4	0.2	N	60.0	48.5	49.1	10.9	50.0	25.0	25.6	24.5
16.50	0.5	0.2	N	60.0	47.6	48.3	11.7	50.0	16.4	17.1	32.9
16.85	0.5	0.2	N	60.0	48.1	48.8	11.3	50.0	19.4	20.1	29.9
20.80	0.6	0.4	L	60.0	49.9	50.9	9.1	50.0	17.4	18.4	31.6
21.60	0.6	0.3	L	60.0	47.4	48.3	11.7	50.0	16.3	17.2	32.8
21.75	0.6	0.3	L	60.0	43.9	44.8	15.2	50.0	14.4	15.3	34.7
22.40	0.6	0.3	N	60.0	48.7	49.6	10.5	50.0	14.5	15.4	34.6

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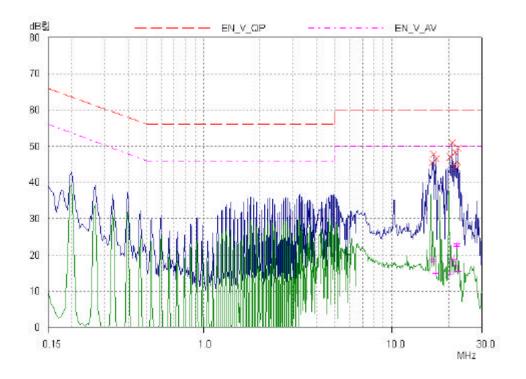
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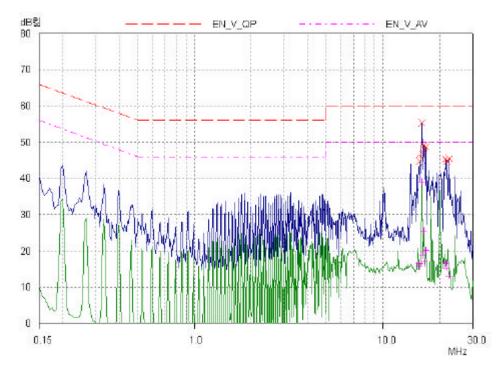
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Radiated Electric Field Emissions (Quasi-Peak reading)

Frequency	Reading	Pol.	Height		Correction Factor		Result	Margin
[MHz]	[dBuV/m]		[m]	Antenna	Cable	[dBuV/m]	[dBuV/m]	[dB]
106.30	11.8	V	1.1	9.50	2.00	30.0	23.29	6.71
108.30	15.4	V	1.0	9.50	2.00	30.0	26.92	3.08
111.70	12.8	V	1.0	9.55	2.00	30.0	24.37	5.63
125.90	11.7	V	1.3	9.40	2.10	30.0	23.23	6.77
156.20	14.7	Н	3.5	7.50	2.50	30.0	24.68	5.32
162.30	16.9	Н	3.8	7.30	2.60	30.0	26.80	3.20
216.30	15.8	Н	3.8	7.95	2.90	30.0	26.60	3.40
499.50	12.7	Н	3.5	15.60	4.70	37.0	32.96	4.04
863.50	5.6	Н	3.8	20.10	6.60	37.0	32.30	4.70

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